RENESAS FemtoClock[®] NG Universal Frequency Translator with Phase Build-Out

IDT8T49N205I

General Description

The IDT8T49N205I is a highly flexible FemtoClock® NG general purpose, low phase noise Frequency Translator / Synthesizer with Phase Build-Out (PBO) suitable for networking and communications applications. It is able to generate any output frequency in the 0.98MHz - 312.5MHz range and most output frequencies in the 312.5MHz - 1,300MHz range (see Table 3 for details). A wide range of input reference clocks and a range of low-cost fundamental mode crystal frequencies may be used as the source for the output frequency.

The IDT8T49N205I has three operating modes to support a very broad spectrum of applications:

- **Frequency Synthesizer**
	- **•** Synthesizes output frequencies from a 16MHz 40MHz fundamental mode crystal.
	- **•** Fractional feedback division is used, so there are no requirements for any specific crystal frequency to produce the desired output frequency with a high degree of accuracy.
- 2) High-Bandwidth Frequency Translator
	- **•** Applications: PCI Express, Computing, General Purpose
	- **•** Translates any input clock in the 16MHz 710MHz frequency range into any supported output frequency.
	- **•** This mode has a high PLL loop bandwidth in order to track input reference changes, such as Spread-Spectrum Clock modulation, so it will not attenuate much jitter on the input reference.
- 3) Low-Bandwidth Frequency Translator
	- **•** Applications: Networking & Communications.
	- **•** Translates any input clock in the 8kHz -710MHz frequency range into any supported output frequency.
	- **•** This mode supports PLL loop bandwidths in the 10Hz 580Hz range and makes use of an external crystal to provide significant jitter attenuation.

This device provides two factory-programmed default power-up configurations burned into One-Time Programmable (OTP) memory. The configuration to be used is selected by the CONFIG pin. The two configurations are specified by the customer and are programmed by IDT during the final test phase from an on-hand stock of blank devices. The two configurations may be completely independent of one another.

One usage example might be to install the device on a line card with two optional daughter cards: an OC-12 option requiring a 622.08MHz LVDS clock translated from a 19.44MHz input and a Gigabit Ethernet option requiring a 125MHz LVPECL clock translated from the same 19.44MHz input reference.

To implement other configurations, these power-up default settings can be overwritten after power-up using the I²C interface and the device can be completely reconfigured. However, these settings would have to be re-written next time the device powers-up.

Features

- **•** Fourth Generation FemtoClock® NG technology
- **•** Universal Frequency Translator/Frequency Synthesizer
	- **•** Zero ppm frequency translation
- **•** Two outputs, individually programmable as LVPECL or LVDS
	- **•** Both outputs may be set to use 2.5V or 3.3V output levels
	- **•** Programmable output frequency: 0.98MHz up to 1,300MHz
- **•** Two differential inputs support the following input types: LVPECL, LVDS, LVHSTL, HCSL
	- **•** Input frequency range: 8kHz 710MHz
- **•** Phase Build-Out minimizes output phase change on switchover
- **•** Crystal input frequency range: 16MHz 40MHz
- **•** Two factory-set register configurations for power-up default state
	- **•** Power-up default configuration pin or register selectable
	- **•** Configurations customized via One-Time Programmable ROM
	- Settings may be overwritten after power-up via l²C
	- **•** I ²C Serial interface for register programming
- **•** RMS phase jitter at 155.52MHz, using a 40MHz crystal (12kHz - 20MHz): 378fs (typical), Low Bandwidth Mode (FracN)
- **•** Output supply voltage modes: $V_{CC}/V_{CCA}/V_{CCO}$
	- 3.3V/3.3V/3.3V 3.3V/3.3V/2.5V 2.5V/2.5V/2.5V
- **•** -40°C to 85°C ambient operating temperature

Pin Assignment

Complete Block Diagram

Pin Descriptions and Characteristics

Table 1. Pin Descriptions

NOTE: Pullup and Pulldown refer to internal input resistors. See Table 2, Pin Characteristics, for typical values.

Table 2. Pin Characteristics

Functional Description

The IDT8T49N205I is designed to provide two copies of almost any desired output frequency within its operating range (0.98 - 1300MHz) from any input source in the operating range (8kHz - 710MHz). It is capable of synthesizing frequencies from a crystal or crystal oscillator source. The output frequency is generated regardless of the relationship to the input frequency. The output frequency will be exactly the required frequency in most cases. In most others, it will only differ from the desired frequency by a few ppb. IDT configuration software will indicate the frequency error, if any. The IDT8T49N205I can translate the desired output frequency from one of two input clocks. Again, no relationship is required between the input and output frequencies in order to translate to the output clock rate. In this frequency translation mode, a low-bandwidth, jitter attenuation option is available that makes use of an external fixed-frequency crystal or crystal oscillator to translate from a noisy input source. If the input clock is known to be fairly clean or if some modulation on the input needs to be tracked, then the high-bandwidth frequency translation mode can be used, without the need for the external crystal.

The input clock references and crystal input are monitored continuously and appropriate alarm outputs are raised both as register bits and hard-wired pins in the event of any out-of-specification conditions arising. Clock switching is supported in manual, revertive & non-revertive modes.

The IDT8T49N205I has two factory-programmed configurations that may be chosen from as the default operating state after reset. This is intended to allow the same device to be used in two different applications without any need for access to the $I²C$ registers. These defaults may be over-written by I^2C register access at any time, but those over-written settings will be lost on power-down. Please contact IDT if a specific set of power-up default settings is desired.

Configuration Selection

The IDT8T49N205I comes with two factory-programmed default configurations. When the device comes out of power-up reset the selected configuration is loaded into operating registers. The IDT8T49N205I uses the state of the CONFIG pin or CONFIG register bit (controlled by the CFG_PIN_REG bit) to determine which configuration is active. When the output frequency is changed either via the CONFIG pin or via internal registers, the output behavior may not be predictable during the register writing and output settling periods. Devices sensitive to glitches or runt pulses may have to be reset once reconfiguration is complete.

Once the device is out of reset, the contents of the operating registers can be modified by write access from the I²C serial port. Users that have a custom configuration programmed may not require I²C access.

It is expected that the IDT8T49N205I will be used almost exclusively in a mode where the selected configuration will be used from device power-up without any changes during operation. For example, the

device may be designed into a communications line card that supports different I/O modules such as a standard OC-12 module running at 622.08MHz or a (255/237) FEC rate OC-12 module running at 669.32MHz. The different I/O modules would result in a different level on the CONFIG pin which would select different divider ratios within the IDT8T49N205I for the two different card configurations. Access via I²C would not be necessary for operation using either of the internal configurations.

Operating Modes

The IDT8T49N205I has three operating modes which are set by the MODE_SEL[1:0] bits. There are two frequency translator modes low bandwidth and high bandwidth and a frequency synthesizer mode. The device will operate in the same mode regardless of which configuration is active.

Please make use of IDT-provided configuration applications to determine the best operating settings for the desired configurations of the device.

Output Dividers & Supported Output Frequencies

In all 3 operating modes, the output stage behaves the same way, but different operating frequencies can be specified in the two configurations.

The internal VCO is capable of operating in a range anywhere from 1.995GHz - 2.6GHz. It is necessary to choose an integer multiplier of the desired output frequency that results in a VCO operating frequency within that range. The output divider stage N[10:0] is limited to selection of integers from 2 to 2046. Please refer to Table 3 for the values of N applicable to the desired output frequency.

Frequency Synthesizer Mode

This mode of operation allows an arbitrary output frequency to be generated from a fundamental mode crystal input. For improved phase noise performance, the crystal input frequency may be doubled. As can be seen from the block diagram in Figure 1, only the upper feedback loop is used in this mode of operation. It is recommended that CLK0 and CLK1 be left unused in this mode of operation.

The upper feedback loop supports a delta-sigma fractional feedback divider. This allows the VCO operating frequency to be a non-integer multiple of the crystal frequency. By using an integer multiple only, lower phase noise jitter on the output can be achieved, however the use of the delta-sigma divider logic will provide excellent performance on the output if a fractional divisor is used.

Figure 1. Frequency Synthesizer Mode Block Diagram

High-Bandwidth Frequency Translator Mode

This mode of operation is used to translate one of two input clocks of the same nominal frequency into an output frequency with little jitter attenuation. As can be seen from the block diagram in Figure 2, similarly to the Frequency Synthesizer mode, only the upper feedback loop is used.

The input reference frequency range is now extended up to 710MHz. A pre-divider stage P is needed to keep the operating frequencies at the phase detector less than 100MHz.

Low-Bandwidth Frequency Translator Mode

As can be seen from the block diagram in Figure 3, this mode involves two PLL loops. The lower loop with the large integer dividers is the low bandwidth loop and it sets the output-to-input frequency translation ratio.This loop drives the upper DCXO loop (digitally controlled crystal oscillator) via an analog-digital converter.

Figure 3. Low Bandwidth Frequency Translator Mode Block Diagram

The pre-divider stage is used to scale down the input frequency by an integer value to achieve a frequency in this range. By dividing down the fed-back VCO operating frequency by the integer divider M1[16:0] to as close as possible to the same frequency, exact output frequency translations can be achieved. For improved phase noise performance, the crystal input frequency may be doubled. The phase detector of the lower loop is designed to work with frequencies in the 8kHz - 16kHz range. For improved phase noise performance, the crystal input frequency may be doubled.

Alarm Conditions & Status Bits

The IDT8T49N205I monitors a number of conditions and reports their status via both output pins and register bits. All alarms will behave as indicated below in all modes of operation, but some of the conditions monitored have no valid meaning in some operating modes. For example, the status of CLK0BAD, CLK1BAD and CLK_ACTIVE are not relevant in Frequency Synthesizer mode. The outputs will still be active and it is left to the user to determine which to monitor and how to respond to them based on the known operating mode.

CLK_ACTIVE - indicates which input clock reference is being used to derive the output frequency.

LOCK IND - This status is asserted on the pin & register bit when the PLL is locked to the appropriate input reference for the chosen mode of operation. The status bit will not assert until frequency lock has been achieved, but will de-assert once lock is lost.

XTALBAD - indicates if valid edges are being received on the crystal input. Detection is performed by comparing the input to the feedback signal at the upper loop's Phase / Frequency Detector (PFD). If three edges are received on the feedback without an edge on the crystal input, the XTALBAD alarm is asserted on the pin & register bit. Once an edge is detected on the crystal input, the alarm is immediately deasserted.

CLK0BAD - indicates if valid edges are being received on the CLK0 reference input. Detection is performed by comparing the input to the feedback signal at the appropriate Phase / Frequency Detector (PFD). When operating in high-bandwidth mode, the feedback at the upper PFD is used. In low-bandwidth mode, the feedback at the lower PFD is used. If three edges are received on the feedback without an edge on the divided down (÷P) CLK0 reference input, the CLK0BAD alarm is asserted on the pin & register bit. Once an edge is detected on the CLK0 reference input, the alarm is deasserted.

CLK1BAD - indicates if valid edges are being received on the CLK1 reference input. Behavior is as indicated for the CLK0BAD alarm, but with the CLK1 input being monitored and the CLK1BAD output pin & register bits being affected.

HOLDOVER - indicates that the device is not locked to a valid input reference clock. This can occur in Manual switchover mode if the selected reference input has gone bad, even if the other reference input is still good. In automatic mode, this will only assert if both input references are bad.

Input Reference Selection and Switching

When operating in Frequency Synthesizer mode, the CLK0 and CLK1 inputs are not used and the contents of this section do not apply. Except as noted below, when operating in either High or Low Bandwidth Frequency Translator mode, the contents of this section apply equally when in either of those modes.

Both input references CLK0 and CLK1 must be the same nominal frequency. These may be driven by any type of clock source, including crystal oscillator modules. A difference in frequency may cause the PLL to lose lock when switching between input references. Please contact IDT for the exact limits for your situation.

The global control bits AUTO_MAN[1:0] dictate the order of priority and switching mode to be used between the CLK0 and CLK1 inputs.

Manual Switching Mode

When the AUTO_MAN[1:0] field is set to Manual via Pin, then the IDT8T49N205I will use the CLK_SEL input pin to determine which input to use as a reference. Similarly, if set to Manual via Register, then the device will use the CLK_SEL register bit to determine the input reference. In either case, the PLL will lock to the selected reference if there is a valid clock present on that input.

If there is not a valid clock present on the selected input, the IDT8T49N205I will go into holdover (Low Bandwidth Frequency Translator mode) or free-run (High Bandwidth Frequency Translator mode) state. In either case, the HOLDOVER alarm will be raised. This will occur even if there is a valid clock on the non-selected reference input. The device will recover from holdover / free-run state once a valid clock is re-established on the selected reference input.

The IDT8T49N205I will only switch input references on command from the user. The user must either change the CLK_SEL register bit (if in Manual via Register) or CLK_SEL input pin (if in Manual via Pin).

Automatic Switching Mode

When the AUTO_MAN[1:0] field is set to either of the automatic selection modes (Revertive or Non-Revertive), the IDT8T49N205I determines which input reference it prefers / starts from by the state of the CLK_SEL register bit only. The CLK_SEL input pin is not used in either Automatic switching mode.

When starting from an unlocked condition, the device will lock to the input reference indicated by the CLK_SEL register bit. It will not pay attention to the non-selected input reference until a locked state has been achieved. This is necessary to prevent 'hunting' behavior during the locking phase.

Once the IDT8T49N205I has achieved a stable lock, it will remain locked to the preferred input reference as long as there is a valid clock on it. If at some point, that clock fails, then the device will automatically switch to the other input reference as long as there is a valid clock there. If there is not a valid clock on either input reference, the IDT8T49N205I will go into holdover (Low Bandwidth Frequency Translator mode) or free-run (High Bandwidth Frequency Translator mode) state. In either case, the HOLDOVER alarm will be raised.

The device will recover from holdover / free-run state once a valid clock is re-established on either reference input. If clocks are valid on both input references, the device will choose the reference indicated by the CLK_SEL register bit.

If running from the non-preferred input reference and a valid clock returns, there is a difference in behavior between Revertive and Non-revertive modes. In Revertive mode, the device will switch back to the reference indicated by the CLK_SEL register bit even if there is still a valid clock on the non-preferred reference input. In Non-revertive mode, the IDT8T49N205I will not switch back as long as the non-preferred input reference still has a valid clock on it.

Switchover Behavior of the PLL

Even though the two input references have the same nominal frequency, there may be minor differences in frequency and potentially large differences in phase between them. The IDT8T49N205I has two options: Phase Build-Out or Phase-Slope Limiting to determine how it will adjust its output to the new input reference when operating in Low-Bandwidth mode. Only Phase-Slope limiting is available in High-Bandwidth mode. The PBO_DISABLE bit is used to determine which method is used in Low_bandwidth mode.

In Phase Slope Limiting operation, the IDT8T49N205I will adjust the output phase at a fixed maximum rate until the output phase and frequency are now aligned to the new input reference. Phase will always be adjusted so that no unacceptably short clock periods are generated on the output of the IDT8T49N205I. Please contact IDT if more information on the maximum phase slope adjustment rate is needed.

In Phase Build-Out operation, the device will absorb most of the phase difference between the two inputs (or between the input and current VCO setting if recovering from holdover). Please refer to

Table 6 for exact limits. Any phase difference that is not absorbed will be reflected on the output at the same maximum rate as in Phase Slope Limiting operation.

Holdover / Free-run Behavior

When both input references have failed (Automatic mode) or the selected input has failed (Manual mode), the IDT8T49N205I will enter holdover (Low Bandwidth Frequency Translator mode) or free-run (High Bandwidth Frequency Translator mode) state .

If operating in Low Bandwidth Frequency Translation mode, the PLL will continue to reference itself to the local oscillator and will hold its output phase and frequency in relation to that source. Output stability is determined by the stability of the local oscillator in this case.

However, if operating in High Bandwidth Frequency Translation mode, the PLL no longer has any frequency reference to use and the VCO will return to the center of its tuning range. Similarly, if operating in Low-Bandwidth mode and no initial frequency lock has been achieved, the VCO will stay at or return to the center of its tuning range.

If the device is programmed to perform Manual switching, once the selected input reference recovers, the IDT8T49N205I will switch back to that input reference. If programmed for either Automatic mode, the device will switch back to whichever input reference has a valid clock first.

The switchover that results from returning from holdover or free-run is handled in the same way as a switch between two valid input references as described in the previous section.

Output Configuration

The two outputs of the IDT8T49N205I both provide the same clock frequency. Both must operate from the same output voltage level of 3.3V or 2.5V, although this output voltage may be less than or equal to the core voltage (3.3V or 2.5V) the rest of the device is operating from. The output voltage level used on the two outputs is supplied on the V_{CCO} pin.

The two outputs are individually selectable as LVDS or LVPECL output types via the Q0_TYPE and Q1_TYPE register bits. These two selection bits are provided in each configuration to allow different output type settings under each configuration.

The two outputs can be enabled individually also via both register control bits and input pins. When both the OEn register bit and OEn pin are enabled, then the appropriate output is enabled. The OEn register bits default to enabled so that by default the outputs can be directly controlled by the input pins. Similarly, the input pins are provisioned with weak pull-ups so that if they are left unconnected, the output state can be directly controlled by the register bits. When the differential output is in the disabled state, it will show a high impedance condition.

Serial Interface Configuration Description

The IDT8T49N205I has an I²C-compatible configuration interface to access any of the internal registers (Table 4D) for frequency and PLL parameter programming. The IDT8T49N205I acts as a slave device on the I2C bus and has the address 0b11011xx, where xx is set by the values on the S_A0 & S_A1 pins (see Table 4A for details). The interface accepts byte-oriented block write and block read operations. An address byte (P) specifies the register address (Table 4D) as the byte position of the first register to write or read. Data bytes (registers) are accessed in sequential order from the lowest to the highest byte (most significant bit first, see table 4B, 4C). Read

and write block transfers can be stopped after any complete byte transfer. It is recommended to terminate I^2C the read or write transfer after accessing byte #23.

For full electrical I^2C compliance, it is recommended to use external pull-up resistors for SDATA and SCLK. The internal pull-up resistors have a size of $50k\Omega$ typical.

Note: if a different device slave address is desired, please contact IDT.

Table 4A. I2C Device Slave Address

Table 4B. Block Write Operation

Table 4C. Block Read Operation

Register Descriptions

Please consult IDT for configuration software and/or programming guides to assist in selection of optimal register settings for the desired configurations.

Table 4D. I2**C Register Map**

Register Bit Color Key

The register bits described in Table 4E are duplicated, with one set applying for Configuration 0 and the other for Configuration 1. The functions of the bits are identical, but only apply when the

configuration they apply to is enabled. Replace the lowercase n in the bit field description with 0 or 1 to find the field's location in the bitmap in Table 4D.

Table 4E. Configuration-Specific Control Bits

Table 4F. Global Control Bits

Table 4G. Global Status Bits

Table 4H. BW[6:0] Bits

Table 4J. Upper Loop (PLL2) Bandwidth Settings

NOTE: To achieve 4MHz bandwidth, reference to the phase detector should be 80MHz.

Absolute Maximum Ratings

NOTE: Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These ratings are stress specifications only. Functional operation of product at these conditions or any conditions beyond those listed in the DC Characteristics or AC Characteristics is not implied. Exposure to absolute maximum rating conditions for extended periods may affect product reliability.

DC Electrical Characteristics

Table 5A. LVPECL Power Supply DC Characteristics, $V_{CC} = V_{CCO} = 3.3V \pm 5\%$ **,** $V_{EE} = 0V$ **,** $T_A = -40^{\circ}C$ **to 85°C**

Table 5C. LVPECL Power Supply DC Characteristics, $V_{CC} = V_{CCO} = 2.5V \pm 5\%$ **,** $V_{EE} = 0V$ **,** $T_A = -40^{\circ}C$ **to 85°C**

Table 5D. LVDS Power Supply DC Characteristics, $V_{CC} = V_{CCO} = 3.3V \pm 5\%$, $T_A = -40^{\circ}$ C to 85°C

Table 5E. LVDS Power Supply DC Characteristics, $V_{CC} = 3.3V \pm 5\%$, $V_{CCO} = 2.5V \pm 5\%$, $T_A = -40^{\circ}$ C to 85°C

Table 5F. LVDS Power Supply DC Characteristics, $V_{CC} = V_{CCO} = 2.5V \pm 5\%$ **,** $T_A = -40^{\circ}C$ **to 85°C**

Table 5G. LVCMOS/LVTTL DC Characteristics, T_A = -40°C to 85°C

Table 5H. Differential DC Characteristics, $V_{CC} = V_{CCO} = 3.3V \pm 5\%$ or 2.5V $\pm 5\%$, $V_{EE} = 0V$, $T_A = -40\degree$ C to 85 \degree C

| Symbol | Parameter | | Test Conditions | Minimum | Typical | Maximum | Units |
|------------------------|---|-----------------------------|---|----------------|----------------|----------------|--------------|
| $I_{\rm IH}$ | Input High Current | CLK0, nCLK0, CLK1, nCLK1 | $V_{\text{CC}} = V_{\text{IN}} = 3.465V$ or 2.625V | | | 150 | μA |
| $I_{\rm IL}$ | Input Low Current | CLK0, CLK1 | V_{CC} = 3.465V or 2.625V, V_{IN} = 0V | -5 | | | μA |
| | | nCLK0, nCLK1 | V_{CC} = 3.465V or 2.625V, V _{IN} = 0V | -150 | | | μA |
| V_{PP} | Peak-to-Peak Voltage | | | 0.15 | | 1.3 | v |
| V_{CMR} | Common Mode Input Voltage; NOTE ₁ | | | V_{FF} + 0.5 | | V_{CC} – 1.0 | v |

NOTE 1: Common mode input voltage is defined as the crosspoint voltage.

Table 5I. LVPECL DC Characteristics, $V_{CC} = V_{CCO} = 3.3V \pm 5\%$, $V_{EE} = 0V$, $T_A = -40^{\circ}$ C to 85°C

NOTE 1: Outputs terminated with 50 Ω to $V_{CCO} - 2V$.

Table 5J. LVPECL DC Characteristics, $V_{CC} = 3.3V \pm 5\%$ or $2.5V \pm 5\%$, $V_{CCO} = 2.5V \pm 5\%$, $V_{EE} = 0V$, $T_A = -40\degree$ C to 85 \degree C

NOTE 1: Outputs terminated with 50 Ω to $V_{CCO} - 2V$.

Table 5K. LVDS DC Characteristics, $V_{CC} = V_{CCO} = 3.3V \pm 5\%$, $V_{EE} = 0V$, $T_A = -40^{\circ}C$ to 85°C

| Symbol | Parameter | Test Conditions | Minimum | Typical | Maximum | Units |
|-----------------|----------------------------------|------------------------|----------------|----------------|----------------|--------------|
| V_{OD} | Differential Output Voltage | | 247 | | 454 | mV |
| ΔV_{OD} | V _{OD} Magnitude Change | | | | 50 | mV |
| V_{OS} | Offset Voltage | | 1.125 | | 1.375 | |
| ΔV_{OS} | V _{OS} Magnitude Change | | | | 50 | mV |

Table 5L. LVDS DC Characteristics, $V_{CC} = 3.3V \pm 5\%$ or $2.5V \pm 5\%$, $V_{CCO} = 2.5V \pm 5\%$, $V_{EE} = 0V$, $T_A = -40^{\circ}$ C to 85° C

Table 6. Input Frequency Characteristics, $V_{CC} = V_{CCO} = 3.3V \pm 5\%$, $T_A = -40^{\circ}$ C to 85°C

NOTE 1: For the input crystal and CLKx, nCLKx frequency range, the M value must be set for the VCO to operate within the 1995MHz to 2600MHz range.

Table 7. Crystal Characteristics

AC Electrical Characteristics

Table 8. AC Characteristics, $V_{CC} = V_{CCO} = 3.3V \pm 5\%$ or 2.5V $\pm 5\%$, or $\rm V_{CC}$ = 3.3V±5%, V \rm_{CCO} = 2.5V±5% (LVPECL Only), V \rm_{EE} = 0V, T \rm_A = -40°C to 85°C

NOTE: Electrical parameters are guaranteed over the specified ambient operating temperature range, which is established when the device is mounted in a test socket with maintained transverse airflow greater than 500 lfpm. The device will meet specifications after thermal equilibrium

has been reached under these conditions.

NOTE 1: Measured using a Rohde & Schwarz SMA100 Signal Generator, 9kHz to 6GHz as the input source.

NOTE 2: This parameter is defined in accordance with JEDEC Standard 65.

NOTE 3: Defined as skew between outputs at the same supply voltage and with equal load conditions. Measured at the output differential cross points.

NOTE 4: This settling time does not include PLL re-calibration and locking if required. Since those times are highly dependent on the specific configuration, please contact IDT for times if PLL re-configuration is performed as part of the configuration change.

NOTE 5: Measurements are collected with the following output frequencies: 19.44MHz, 38.88MHz, 66.6667Mhz, 125MHz, 156.25MHz, 161.1328125MHz, 311.04MHz, 400MHz, 480MHz, 622.08MHz 1000MHz, 1200MHz, 1300MHz.

IDT8T49N205I Data Sheet FEMTOCLOCK® NG UNIVERSAL FREQUENCY TRANSLATOR WITH PHASE BUILD-OUT

Typical Phase Noise at 400MHz (3.3V)

Parameter Measurement Information

3.3 Core/3.3V LVPECL Output Load Test Circuit

3.3 Core/2.5V LVPECL Output Load Test Circuit

2.5 Core/2.5V LVDS Output Load Test Circuit

2.5 Core/2.5V LVPECL Output Load Test Circuit

3.3 Core/3.3V LVDS Output Load Test Circuit

3.3 Core/2.5V LVDS Output Load Test Circuit

IDT8T49N205I Data Sheet FEMTOCLOCK® NG UNIVERSAL FREQUENCY TRANSLATOR WITH PHASE BUILD-OUT

Parameter Measurement Information, continued

Cycle-to-Cycle Jitter

LVDS Output Rise/Fall Time

RMS Period Jitter

LVPECL Output Rise/Fall Time

IDT8T49N205I Data Sheet FEMTOCLOCK® NG UNIVERSAL FREQUENCY TRANSLATOR WITH PHASE BUILD-OUT

Parameter Measurement Information, continued

Offset Voltage Setup

Differential Output Duty Cycle/Output Pulse Width/Period

Differential Output Voltage Setup

Applications Information

Recommendations for Unused Input and Output Pins

Inputs:

CLKx/nCLKx Inputs

For applications not requiring the use of either differential input, both CLKx and nCLKx can be left floating. Though not required, but for additional protection, a 1k Ω resistor can be tied from CLKx to ground. It is recommended that CLKx, nCLKx be left unconnected in frequency synthesizer mode.

LVCMOS Control Pins

All control pins have internal pullups or pulldowns; additional resistance is not required but can be added for additional protection. A 1 $k\Omega$ resistor can be used.

Outputs:

LVPECL Outputs

All unused LVPECL output pairs can be left floating. We recommend that there is no trace attached. Both sides of the differential output pair should either be left floating or terminated.

LVDS Outputs

All unused LVDS output pairs can be either left floating or terminated with 100 Ω across. If they are left floating there should be no trace attached.

LVCMOS Outputs

All unused LVCMOS outputs can be left floating. There should be no trace attached.

Recommended Values for Low-Bandwidth Mode Loop Filter

External loop filter components are not needed in Frequency Synthesizer or High-Bandwidth modes. In Low-Bandwidth mode, the loop filter structure and components shown in Figure 11 are recommended. Please consult IDT if other values are needed.

Wiring the Differential Input to Accept Single-Ended Levels

Figure 4 shows how a differential input can be wired to accept single ended levels. The reference voltage $V_1 = V_{C}C/2$ is generated by the bias resistors R1 and R2. The bypass capacitor (C1) is used to help filter noise on the DC bias. This bias circuit should be located as close to the input pin as possible. The ratio of R1 and R2 might need to be adjusted to position the V_1 in the center of the input voltage swing. For example, if the input clock swing is 2.5V and $V_{CC} = 3.3V$, R1 and R2 value should be adjusted to set V_1 at 1.25V. The values below are for when both the single ended swing and V_{CC} are at the same voltage. This configuration requires that the sum of the output impedance of the driver (Ro) and the series resistance (Rs) equals the transmission line impedance. In addition, matched termination at the input will attenuate the signal in half. This can be done in one of two ways. First, R3 and R4 in parallel should equal the transmission

line impedance. For most 50 Ω applications, R3 and R4 can be 100 Ω . The values of the resistors can be increased to reduce the loading for slower and weaker LVCMOS driver. When using single-ended signaling, the noise rejection benefits of differential signaling are reduced. Even though the differential input can handle full rail LVCMOS signaling, it is recommended that the amplitude be reduced. The datasheet specifies a lower differential amplitude, however this only applies to differential signals. For single-ended applications, the swing can be larger, however V_{II} cannot be less than -0.3V and V_{IH} cannot be more than V_{CC} + 0.3V. Though some of the recommended components might not be used, the pads should be placed in the layout. They can be utilized for debugging purposes. The datasheet specifications are characterized and guaranteed by using a differential signal.

Figure 4. Recommended Schematic for Wiring a Differential Input to Accept Single-ended Levels

Overdriving the XTAL Interface

The XTAL_IN input can be overdriven by an LVCMOS driver or by one side of a differential driver through an AC coupling capacitor. The XTAL_OUT pin can be left floating. The amplitude of the input signal should be between 500mV and 1.8V and the slew rate should not be less than 0.2V/nS. For 3.3V LVCMOS inputs, the amplitude must be reduced from full swing to at least half the swing in order to prevent signal interference with the power rail and to reduce internal noise. Figure 5A shows an example of the interface diagram for a high speed 3.3V LVCMOS driver. This configuration requires that the sum of the output impedance of the driver (Ro) and the series resistance (Rs) equals the transmission line impedance. In addition, matched termination at the crystal input will attenuate the signal in half. This

can be done in one of two ways. First, R1 and R2 in parallel should equal the transmission line impedance. For most 50Ω applications, R1 and R2 can be 100 Ω . This can also be accomplished by removing R1 and changing R2 to 50 Ω . The values of the resistors can be increased to reduce the loading for a slower and weaker LVCMOS driver. Figure 5B shows an example of the interface diagram for an LVPECL driver. This is a standard LVPECL termination with one side of the driver feeding the XTAL_IN input. It is recommended that all components in the schematics be placed in the layout. Though some components might not be used, they can be utilized for debugging purposes. The datasheet specifications are characterized and guaranteed by using a quartz crystal as the input.

Figure 5A. General Diagram for LVCMOS Driver to XTAL Input Interface

Figure 5B. General Diagram for LVPECL Driver to XTAL Input Interface

Differential Clock Input Interface

The CLK /nCLK accepts LVDS, LVPECL, LVHSTL, HCSL and other differential signals. Both V_{SWING} and V_{OH} must meet the V_{PP} and V_{CMB} input requirements. Figures 6A to 6E show interface examples for the CLK/nCLK input driven by the most common driver types. The input interfaces suggested here are examples only. Please consult

with the vendor of the driver component to confirm the driver termination requirements. For example, in Figure 8A, the input termination applies for IDT open emitter LVHSTL drivers. If you are using an LVHSTL driver from another vendor, use their termination recommendation.

Figure 6A. CLK/nCLK Input Driven by an IDT Open Emitter LVHSTL Driver

Figure 6C. CLK/nCLK Input Driven by a 3.3V LVPECL Driver

Figure 6E. CLK/nCLK Input Driven by a 3.3V HCSL Driver

Figure 6B. CLK/nCLK Input Driven by a 3.3V LVPECL Driver

Figure 6D. CLK/nCLK Input Driven by a 3.3V LVDS Driver

LVDS Driver Termination

For a general LVDS interface, the recommended value for the termination impedance (Z_T) is between 90 Ω and 132 Ω . The actual value should be selected to match the differential impedance (Z_0) of your transmission line. A typical point-to-point LVDS design uses a 100 Ω parallel resistor at the receiver and a 100 Ω differential transmission-line environment. In order to avoid any transmission-line reflection issues, the components should be surface mounted and must be placed as close to the receiver as possible. IDT offers a full line of LVDS compliant devices with two types of output structures: current source and voltage source. The

standard termination schematic as shown in Figure 7A can be used with either type of output structure. Figure 7B, which can also be used with both output types, is an optional termination with center tap capacitance to help filter common mode noise. The capacitor value should be approximately 50pF. If using a non-standard termination, it is recommended to contact IDT and confirm if the output structure is current source or voltage source type. In addition, since these outputs are LVDS compatible, the input receiver's amplitude and common-mode input range should be verified for compatibility with the output.

LVDS Termination

Termination for 3.3V LVPECL Outputs

The clock layout topology shown below is a typical termination for LVPECL outputs. The two different layouts mentioned are recommended only as guidelines.

The differential outputs are low impedance follower outputs that generate ECL/LVPECL compatible outputs. Therefore, terminating resistors (DC current path to ground) or current sources must be used for functionality. These outputs are designed to drive 50Ω

Figure 8A. 3.3V LVPECL Output Termination Figure 8B. 3.3V LVPECL Output Termination

transmission lines. Matched impedance techniques should be used to maximize operating frequency and minimize signal distortion. Figures 8A and 8B show two different layouts which are recommended only as guidelines. Other suitable clock layouts may exist and it would be recommended that the board designers simulate to guarantee compatibility across all printed circuit and clock component process variations.

Termination for 2.5V LVPECL Outputs

Figure 10A and Figure 9B show examples of termination for 2.5V LVPECL driver. These terminations are equivalent to terminating 50 Ω to V_{CCO} – 2V. For V_{CCO} = 2.5V, the V_{CCO} – 2V is very close to ground

Figure 9A. 2.5V LVPECL Driver Termination Example

Figure 9C. 2.5V LVPECL Driver Termination Example

2.5V LVPECL Driver $V_{\text{CCO}} = 2.5V$ 2.5V 50Ω $50₅$ R1 50 R2 50 R3 18 + –

Figure 9B. 2.5V LVPECL Driver Termination Example

VFQFN EPAD Thermal Release Path

In order to maximize both the removal of heat from the package and the electrical performance, a land pattern must be incorporated on the Printed Circuit Board (PCB) within the footprint of the package corresponding to the exposed metal pad or exposed heat slug on the package, as shown in Figure 10. The solderable area on the PCB, as defined by the solder mask, should be at least the same size/shape as the exposed pad/slug area on the package to maximize the thermal/electrical performance. Sufficient clearance should be designed on the PCB between the outer edges of the land pattern and the inner edges of pad pattern for the leads to avoid any shorts.

While the land pattern on the PCB provides a means of heat transfer and electrical grounding from the package to the board through a solder joint, thermal vias are necessary to effectively conduct from the surface of the PCB to the ground plane(s). The land pattern must be connected to ground through these vias. The vias act as "heat pipes". The number of vias (i.e. "heat pipes") are application specific

and dependent upon the package power dissipation as well as electrical conductivity requirements. Thus, thermal and electrical analysis and/or testing are recommended to determine the minimum number needed. Maximum thermal and electrical performance is achieved when an array of vias is incorporated in the land pattern. It is recommended to use as many vias connected to ground as possible. It is also recommended that the via diameter should be 12 to 13mils (0.30 to 0.33mm) with 1oz copper via barrel plating. This is desirable to avoid any solder wicking inside the via during the soldering process which may result in voids in solder between the exposed pad/slug and the thermal land. Precautions should be taken to eliminate any solder voids between the exposed heat slug and the land pattern. Note: These recommendations are to be used as a guideline only. For further information, please refer to the Application Note on the Surface Mount Assembly of Amkor's Thermally/ Electrically Enhance Lead frame Base Package, Amkor Technology.

Figure 10. P.C. Assembly for Exposed Pad Thermal Release Path – Side View (drawing not to scale)

Schematic Layout

Figure 11 (next page), shows an example of the UFT (8T49N205) application schematic. Input and output terminations shown are intended as examples only and may not represent the exact user configuration. Refer to the pin description and functional tables in the datasheet to ensure the logic control inputs are properly set.

In this example, the device is operated at $V_{CC}=3.3V$. For 2.5V option, please refer to the "Termination for 2.5V LVPECL Outputs" for output termination recommendation. A 12pF parallel resonant Fox FX325BS Series 16MHz to 40MHz crystal is used in this example. Different crystal frequencies may be used. The $C1 = C2 = 5pF$ are recommended for frequency accuracy. If different crystal types are used, please consult IDT for recommendations. For different board layout, the C1 and C2 may be slightly adjusted for optimizing frequency accuracy. It is recommended that the loop filter components be laid out for the 3-pole option. This will also allow either 2-pole or 3-pole filter to be used. The 3-pole filter can be used for additional spur reduction. If a 2-pole filter construction is used, the LF0 and LF1 pins must be tied-together and to the filter.

As with any high speed analog circuitry, the power supply pins are vulnerable to random noise. To achieve optimum jitter performance, power supply isolation is required. The UFT (8T49N205) provides separate V_{CC} , V_{CC} and V_{CC} power supplies to isolate any high switching noise from coupling into the internal PLL.

In order to achieve the best possible filtering, it is highly recommended that the 0.1µF capacitors on the device side of the ferrite beads be placed on the device side of the PCB as close to the power pins as possible. This is represented by the placement of these capacitors in the schematic. If space is limited, the ferrite beads and 10µf capacitors connected to 3.3V can be placed on the opposite side of the PCB. If space permits, place all filter components on the device side of the board.

Power supply filter recommendations are a general guideline to be used for reducing external noise from coupling into the devices. The filter performance is designed for a wide range of noise frequencies. This low-pass filter starts to attenuate noise at approximately 10 kHz. If a specific frequency noise component is known, such as switching power supplies frequencies, it is recommended that component values be adjusted and if required, additional filtering be added. Additionally, good general design practices for power plane voltage stability suggests adding bulk capacitance in the local area of all devices.

LVPECL Power Considerations

This section provides information on power dissipation and junction temperature for the IDT8T49N205I. Equations and example calculations are also provided.

1. Power Dissipation.

The total power dissipation for the IDT8T49N205I is the sum of the core power plus the output power dissipated due to loading. The following is the output power dissipation for $V_{CC} = 3.3V + 5\% = 3.465V$, which gives worst case results.

NOTE: Please refer to Section 3 for details on calculating output power dissipated due to loading.

- Power (core)_{MAX} = $V_{\text{CC_MAX}}$ * $I_{\text{EE_MAX}}$ = 3.465V * 320mA = **1108.8W**
- Power (outputs)_{MAX} = 33.2mW/Loaded Output pair If all outputs are loaded, the total power is 2 * 33.2mW = **66.4mW**

Total Power_{$-MAX$} (3.465V, with all outputs switching) = 1108.8mW + 66.4mW = 1175.2mW

2. Junction Temperature.

Junction temperature, Tj, is the temperature at the junction of the bond wire and bond pad directly affects the reliability of the device. The maximum recommended junction temperature is 125°C. Limiting the internal transistor junction temperature, Tj, to 125°C ensures that the bond wire and bond pad temperature remains below 125°C.

The equation for Tj is as follows: Tj = θ_{JA} * Pd_total + T_A

 Tj = Junction Temperature

 θ_{JA} = Junction-to-Ambient Thermal Resistance

Pd_total = Total Device Power Dissipation (example calculation is in section 1 above)

 T_A = Ambient Temperature

In order to calculate junction temperature, the appropriate junction-to-ambient thermal resistance θ_{JA} must be used. Assuming no air flow and a multi-layer board, the appropriate value is 32.4°C/W per Table 9 below.

Therefore, T_i for an ambient temperature of 85°C with all outputs switching is:

 85° C + 1.175W $*$ 32.4 $^{\circ}$ C/W = 123.1 $^{\circ}$ C. This is below the limit of 125 $^{\circ}$ C.

This calculation is only an example. Tj will obviously vary depending on the number of loaded outputs, supply voltage, air flow and the type of board (multi-layer).

Table 9. Thermal Resistance θ_{JA} for 40 Lead VFQFN, Forced Convection

3. Calculations and Equations.

The purpose of this section is to calculate the power dissipation for the LVPECL output pairs.

LVPECL output driver circuit and termination are shown in Figure 12.

Figure 12. LVPECL Driver Circuit and Termination

To calculate output power dissipation due to loading, use the following equations which assume a 50 Ω load, and a termination voltage of V_{CCO} – 2V.

- For logic high, $V_{OUT} = V_{OH~MAX} = V_{CCO~MAX} 0.7V$ $(V_{\text{CCO_MAX}} - V_{\text{OH_MAX}}) = 0.7V$
- For logic low, $V_{\text{OUT}} = V_{\text{OL_MAX}} = V_{\text{CCO_MAX}} 1.5V$ $(V_{CCO~MAX} - V_{OL~MAX}) = 1.5V$

Pd_H is power dissipation when the output drives high.

Pd L is the power dissipation when the output drives low.

Pd_H = [(V_{OH_MAX} – (V_{CCO_MAX} – 2V))/R_L] * (V_{CCO_MAX} – V_{OH_MAX}) = [(2V – (V_{CCO_MAX} – V_{OH_MAX}))/R_L] * (V_{CCO_MAX} – V_{OH_MAX}) = $[(2V – 0.7V)/50²] * 0.7V = 18.2mW$

Pd_L = [(V_{OL_MAX} – (V_{CCO_MAX} – 2V))/R_L] * (V_{CCO_MAX} – V_{OL_MAX}) = [(2V – (V_{CCO_MAX} – V_{OL_MAX}))/R_{L]} * (V_{CCO_MAX} – V_{OL_MAX}) = $[(2V - 1.5V)/50\Omega]$ * 1.5V = 15mW

Total Power Dissipation per output pair = Pd_H + Pd_L = **33.2mW**

LVDS Power Considerations

This section provides information on power dissipation and junction temperature for the IDT8T49N205I. Equations and example calculations are also provided.

1. Power Dissipation.

The total power dissipation for the IDT8T49N205I is the sum of the core power plus the output power dissipation due to the load. The following is the output power dissipation for $V_{CC} = 3.3V + 5\% = 3.465V$, which gives worst case results.

- Power (core)_{MAX} = V_{CC_MAX} * (l_{CC} _{MAX} + l_{CCA} _{MAX}) = 3.465V * (273mA + 30mA) = **1049.895mW**
- Power (outputs) $_{MAX}$ = V_{CCO_MAX} $*$ l_{CCO_MAX} = 3.465V $*$ 42mA = 145.53mW

Total Power_MAX = 1049.895mW + 145.53mW = **1195.425mW**

2. Junction Temperature.

Junction temperature, Tj, is the temperature at the junction of the bond wire and bond pad directly affects the reliability of the device. The maximum recommended junction temperature is 125°C. Limiting the internal transistor junction temperature, Tj, to 125°C ensures that the bond wire and bond pad temperature remains below 125°C.

The equation for Tj is as follows: Tj = θ_{JA} * Pd_total + T_A

 Tj = Junction Temperature

 θ_{JA} = Junction-to-Ambient Thermal Resistance

Pd_total = Total Device Power Dissipation (example calculation is in section 1 above)

 T_A = Ambient Temperature

In order to calculate junction temperature, the appropriate junction-to-ambient thermal resistance θ_{JA} must be used. Assuming no air flow and a multi-layer board, the appropriate value is 32.4°C/W per Table 10 below.

Therefore, Tj for an ambient temperature of 85° C with all outputs switching is:

85°C + 1.195W $*$ 32.4°C/W = 123.7°C. This is below the limit of 125°C.

This calculation is only an example. Tj will obviously vary depending on the number of loaded outputs, supply voltage, air flow and the type of board (multi-layer).

Table 10. Thermal Resistance θ_{JA} for 40 Lead VFQFN, Forced Convection

Reliability Information

Table 11. θ_{JA} vs. Air Flow Table for a 40 Lead VFQFN

Transistor Count

The transistor count for IDT8T49N205I is: 53,727

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IDT8T49N205I Data Sheet FEMTOCLOCK® NG UNIVERSAL FREQUENCY TRANSLATOR WITH PHASE BUILD-OUT

40 Lead VFQFN Package Outline and Package Dimensions, continued

Ordering Information

Table 12. Ordering Information

NOTE: For the specific -ddd order codes, refer to FemtoClock NG Universal Frequency Translator Ordering Product Information document.

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